INFORMATION			Atty. Docket No.: 56160US015 Serial No.:						
DI	SCLC	DSURE	Applicant(s): William Bedingham, Raj Rajagopal and Michael G. Williams						
CITATION			Filin	Filing Date: Group:					
			U.S	. PATENT	DOCUMENTS	. :			
Examiner Initial		Document Num	iber	Date	Name	Class	SubClass		Date If
NAB		4,565,783		01/21/86	Hansen et al.	435	299		
		5,089,413		02/18/92	Nelson et al.	435	254		
		5,232,838		08/03/93	Nelson et al.	435	30		
		5,364,766		11/15/94	Mach et al.	435	34		
		5,393,662		02/28/95	Roth et al.	435	38		
		5,403,722		04/04/95	Floeder et al.	435	39		
		5,462,860		10/31/95	Mach	435	34		
		5,510,246		04/23/96	Morgan	435	39		
		5,573,950		11/12/96	Graessle et al.	435	287.3		
		5,601,998		02/11/97	Mach et al.	435	34		
		5,681,712		10/28/97	Nelson	435	30		
		5,694,478		12/02/97	Braier et al.	382	133		
		5,723,308		03/03/98	Mach et al.	435	34		
		5,744,322		04/28/98	Krejcarek et al.	435	39		
		5,747,333		05/05/98	Jungmann- Campello et al.	435	283		
NAB		5,928,858		07/27/99	Chao	435	4		
			FORE	IGN PATE	NT DOCUMENTS.		×	•	."
		Document Nun	iber	Date	Country	Class	SubClass	Tran: Yes	lation No
NAB		GB 2 310 006	,	08/13/97	U.K.	F15B	15/14	\	1
NAB		WO 00/25923	3	05/11/00	PCT	B01L	3/02		
								1	1
	OTHE	R DOCUMEN	TS (In	cluding Aut	hors, Title, Date, Pe	rtinent F	apers, et	c.)	
NAB	Brochure "CLONTECH CLONdisc™ Plates - The New Paradigm in Plating",								
NAB	Williams et al., U.S. Patent Application Serial No. 09/541,416, "Device for Propagation and Storage of Microorganisms", filed April 3, 2000								
								. —	
				···········	·				
EXAMI	NER	/Nathan	Bower	s/	Date Considered	06/05/	2006		
*Examiner:	Initial if	reference considered.	whether	or not citation is I	n conformance with MPEP 609	); Draw line	through cites	ion if no	t in
conformanc	e and not	considered. Include c	opy of th	is form with next.	communication to applicant.	::-::			

Based on Form PTO-FB-A820 (Also form PTO-1449)

E						MB No.		
ENFORMATION			Atty. Docket No.: 56160US015			No.: 10/6	98,3	02
	CLOSURE TEMENT						-	
\$TA	Applicant(s): William Bedingham, Raj Rajagopal and							
OER CE TIL	Mic	hael G. Wi	lliams					
DEMB	•	Filir	ng Date: O	ctober 31, 2003	Group	:		
				DOCUMENTS				
Examiner Initial	Document Number	er	. Date	Name	Class	SubClass		Date If opriate
NAB	4,118,280		10/03/78	Charles et al.	195	127		
NAB	4,591,567	1	05/27/86	Britten et al.	435	293		
- NAB	.,,							
	·			·				
	•					ļ	<u> </u>	
						ļ		
						ļ		
<u> </u>	Document Number			NT DOCUMENT Country	S Class	SubClass	T	slation
	Document Number	er	Date	Country	Class	. Subclass	Yes	No
NAB	WO 92/12233	7	97/23/92	PCT	C12M	1/32	Χ	
NAB	WO 01/38559	A2 🗸	05/31/01	PCT	C12Q	1/00	X	
						<u> </u>	ļ	<u> </u>
							<u> </u>	<u></u>
OT	HER DOCUMENT	S (Inc	cluding Au	thors, Title, Date,	Pertinent P	apers, et	c.)	
			· ·					
								·
				····				
EXAMINE	D D		·	Date Considere				
EXAMINE	/Nathan Bo	wers/	,	Date Considere	06/05/20	06		
	ial if reference considered, w					through citati	on if no	ot in
conformance and Based on Form I	d not considered. Include cop PTO-FB-A820	py of this	s torm with next	communication to applica Patent and Trademar		partment of C	ommer	ce
(Also form PTO-								

ubstitute for form 1449A/PTO (modified)	Application Number	10/698302
NFORMATION DISCLOSURE	Filing Date	October 31, 2003
STATEMENT BY APPERSANT	First Named Inventor	Bedingham, William
(Use as many sheets as necessary)	Art Unit	2623
(Use as many sheets as hecessary) 85 (Use 2 1 2004 )	Examiner Name	B. Le
Page 1 of 18 8	Attorney Case Number	56160US015

			, U.S. Patent	Documents		
Exam.	Cite	Document Number	Publication Date or Issue Date	Name of Patentee	Pages, Columns, Lines, Where Relevant Passages or Relevant	
Init.*	No.	Doc. Number-(Kind Code if Known)	MM-DD-YYYY	or Applicant of Cited Document	Figures Appear	
NAB	A1	US- 5,329,686	7/19/94	Kildal et al.		
	A2	US-				
	А3	US-				
	A4	US-				
	A5	US-				
	A6	US-				
	A7	US-				
	A8	US-				
	A9	US-				
	A10	US-				
	A11	US-		·		

			Fo	oreign Patent	Documents		
Exam.	Cite	Foreign Patent Document		Publication Date	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages	Translation
tnit.*	No.	Ctry. Code	Number-KindCode (If known)	MM-DD-YYYY	Applicant of Cited Document	or Relevant Figures Appear	(Check if yes)
NAB	B1	DE	19819144	4/29/98			X
NAB	B2	JP	60-83597	5/11/85	Hitachi Electronics		Х
NAB	В3	JP	2001-242082	7/09/01	Nippon Laser		Х
NAB	B4	wo	02/090966	1/14/02	Large Scale Proteomics Corp.		
	B5						<u> </u>
	В6						
	B7					<b>I</b>	

	OTHER DOCUMENTS							
Exam. Init,*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	Translation (Check if yes)					
	C1							
	C2							
	СЗ							

*Examiner:	/Nathan	Bowers/	Date Considered:	06/05/2006
EXAMINER: Initial if r conformance and not	eference con considered. I	sidered, whether or not citation nclude copy of this form with ne	is in conformance with MPE ext communication to application	P 609. Draw line through citation if not in ant.

## Substitute for form 1449A/PTO (modified)

## **INFORMATION DISCLOSURE TEMENT BY APPLICANT**

Page 1 of 1

Application Number	10/698302
Filing Date	October 31, 2003
First Named Inventor	Bedingham, William
Art Unit	2623
Examiner Name	Unknown
Attorney Case Number	56160US015

ATEN	I & TRA	U.S. Patent Documents							
Exam.	Cite	Document Number	Publication Date or Issue Date	Name of Patentee	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear				
Init.*	No.	Doc. Number-(Kind Code if Known)	MM-DD-YYYY	or Applicant of Cited Document					
NAB	A1	US- 2001/0031502	10/18/01	Watson Jr., et al.					
	A2	US-							
	A3	US-							
	A4	US-							
	A5	US-							
	A6	US-							
	A7	US-							
	A8	US-							
	A9	US-							
	A10	US-							
	A11	US-							

			Fo	oreign Patent	Documents		
Exam.	Cite	For	eign Patent Document	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where Relevant Passages	Translation
lnit.*	No.	Ctry. Code	Number-KindCode (If known)	MM-DD-YYYY	Applicant of Cited Document	or Relevant Figures Appear	(Check if yes)
NAB	B1	wo	03/014400	2/20/03	Applied Precision, LLC		
NAB	B2	wo	03/038413	5/08/03	Diachip Co., Ltd.		
	В3						
	B4						
	B5		·				
	В6						
	B7						

OTHER DOCUMENTS							
Exam. Init.*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	Translation (Check if yes)				
	C1						
	C2						
	СЗ						

Examiner:	/Nathan Bowers/	Date Considered:	06/05/2006

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.